Crystal growth experiments of multicomponent systems under microgravity require an exact analysis of the diffusion phenomena in the nutrient fluid phase. The contribution of the Soret effect to the transport and distribution of matter in a convectionless casting arrangement for shaped crystal growth and in THM melt-solution zones has been investigated. Some semiconductor systems were analysed from experimental (Bi$_{1-x}$Sb$_x$ mixed crystals) and theoretical (PbTe, InP, GaAs, CdTe compounds) point of view. The criterion for constitutional supercooling was correspondingly modified. It has been distinguished between associated (AIV—BVI, AII—BVI) and dissociated (AIII—BV) melt-solutions, containing different species of diffusion (molecules or atoms, respectively).

1. Introduction

For an analysis of crystal growth phenomena under conditions of microgravity (μg), the normal freezing of sealed containers (Bridgman growth, shaped crystal growth by casting), the travelling heater method (THM) and the sublimation-condensation, are advantageous methods (FEUERBACHER et al.). A specific temperature profile is chosen in order to control the interface mass transport rates and to supply the latent heat of fusion, in other words, characteristic uniaxial temperature gradients must be engineered (Fig. 1). Therefore, gradients of temperature in the nutrient phases must exist, leading to buoyancy-driven convection in normal ground based experiments. Conversely under μg conditions and the prevention of Maragoni flows, the mass transfer is dominated by diffusion composed of ordinary Fick flow $j_{OD}$, and thermodiffusive transport $j_{TD}$. The so called Soret effect (SORET) of thermodiffusion is a cross-effect resulting from the interaction between the thermodynamic fluxes of heat and matter in a mixture of two or more components. Both, heat conduction and diffusion are coupled to transport heat and matter from regions which temperature and concentration are not in equilibrium. Therefore, temperature gradients cause concentration gradients in an initially homogeneous solu-
Fig. 1. The principles of diffusion-controlled crystal growth methods usually applied under \( \mu_0 \) conditions (\( T \) — temperature, \( z \) — distance, \( T_g \) — growth temperature, \( T_s \) — solution or sublimation temperature, \( \text{grad} T \) — temperature gradient in the fluid phase, \( v \) — growth rate, \( j_{\text{OD}} \) — ordinary diffusion flow, \( j_{\text{TD}} \) — thermodiffusion flow, \( j_{\text{ST}} \) — Stefan flow).

The total diffusion flow of the solvent B in a solution is

\[
j_B = j_{\text{OD}} + j_{\text{TD}} = -\rho D \text{grad} c_B + c_A c_B D' \text{grad} T
\]

with \( \rho \) being the mass density of the melt-solution, \( D \) the ordinary diffusion coefficient, \( c_A \) and \( c_B \) the concentrations of solute A and solvent B in weight fraction, \( T \) the absolute temperature and \( D' = D_0/c_A c_B = D S_T \) the thermal diffusion coefficient with \( S_T \) the Soret coefficient.

To date, the exact values and even the sign of \( S_T \) of many material systems is unknown (Rosenberg). Current convention assigns a positive value to \( S_T \) when the solvent B is found to be the light component and moves to the hot region. Various practical and theoretical methods to determine the value of \( S_T \) are described. The most convenient experimental procedure appears to be the shear cell arrangement (Nachttrieb). We have carried out the rapid quenching of capillary ampoules, which have remained for an extended time at a constant temperature gradient (Boeck; Schmidt). According to Winter and Drickamer a value may be predicted from the relation

\[
S_T = \frac{m - M}{m c_B + M(1 - c_B)} \frac{\Delta E}{kT^2}
\]

where \( m, M \) are the molecular weights of solute and solvent, respectively, \( \Delta E \) is the activation energy, \( c_B \) the concentration of solvent, \( T \) the absolute temperature and \( k \) the Boltzmann constant.

Particular attention is required for various melt-solutions. It is well known (Jordan) that a much stronger interaction exists between unlike atoms of the II—VI and IV—VI compounds than of the III—V compounds in the molten state. Therefore, a low degree of dissociation \( \beta_1 = 0.05 \), i.e., concentration of separate dissimilar atoms in the II—VI and IV—VI melt solutions, will be obtained and gives rise to separate AB molecules (solute) and atomic solvent B involved in the diffusion fluxes. We have used the physicochemical parameters listed in Table 1.

Depending on the total value and sign of the Soret coefficient, the concentration inhomogeneities in the nutrient will be decreased and will influence the critical growth conditions (maximum growth rate) in comparison with conditions resulting from the ordinary diffusion alone. We have investigated the practical contribution of the Soret effect on the segregation function in convectionless Bridgman-grown Bi\(_{1-x}\)Sb\(_x\) mixed
Table 1
Some physicochemical parameters of semiconductor systems

<table>
<thead>
<tr>
<th>Crystal</th>
<th>Melt</th>
<th>Solvent</th>
<th>T</th>
<th>cB [mass %]</th>
<th>Str x10^-3 K^-1</th>
</tr>
</thead>
<tbody>
<tr>
<td>GaAs</td>
<td>Ga, As</td>
<td>Ga</td>
<td>1073</td>
<td>0.9576</td>
<td>+0.21</td>
</tr>
<tr>
<td>InP</td>
<td>In, P</td>
<td>In</td>
<td>1073</td>
<td>0.9882</td>
<td>-7.51</td>
</tr>
<tr>
<td>PbTe</td>
<td>PbTe, Te</td>
<td>Te</td>
<td>900</td>
<td>0.3226</td>
<td>+2.03</td>
</tr>
<tr>
<td>CdTe</td>
<td>CdTe, Te</td>
<td>Te</td>
<td>1073</td>
<td>0.4437</td>
<td>+1.4</td>
</tr>
<tr>
<td>Bi-Sb</td>
<td>Bi, Sb</td>
<td>Sb</td>
<td>550</td>
<td>0.0020</td>
<td>+2.03</td>
</tr>
</tbody>
</table>

1) Chen, Mattes, 2) Böck, 3) Dismukes, Yim, 4) Schmidt

crystals, and the theoretical distribution of components in THM zones of CdTe:Te, PbTe:Te, GaAs:Ga, and InP:In.

2. Convectionless Bridgman growth in thin moulds

In order to suppress buoyancy- and surface tension-driven convection in melt and melt-solution crystal growth systems at normal gravity (1g), strong axial temperature gradients and as narrow as possible vertical melt columns are desirable. We applied a special Bridgman growth arrangement for Bi_{1-x}Sbx mixed crystals using a micro mould system consisting of parallel optically flat plates made of fused silica (Fig. 2). The ingot chamber for the crystallization process had the dimension 50 mm in length, 5 mm wide and of 1 mm thickness. A linear uniaxial temperature gradient of 15 K cm^-1 was maintained by a pair of Kanthal meanders.

After the positioning of a cleaved single crystal seed on the bottom of the ingot chamber and the heating of the otherwise empty mould to growth temperature, an externally molten starting charge with a mole fraction x = 0.025 was poured through the filling port into the crystallization chamber. The growth process with a crystallization velocity of 0.2 mm h^-1 was achieved by computer-controlled cooling with a rate of 0.3 K h^-1 over a period of 300 h. Monocrystalline, elongated thin laminas of high purity and very good structural perfection were obtained (Rudolph; Schmidt) and the axial concentration distribution were determined by electron probe microanalysis (EPMA). Figure 3 shows the segregation functions of the Sb mole fraction taken from EPMA measurements (Christ et al.)
3. The travelling heater method (THM)

The THM has proved successful in growing of single crystals which are difficult to produce by conventional techniques (Triboulet). A melt-solution zone moves with a constant velocity, beginning at a seed crystal, through a polycrystalline feed ingot. This method is very popular in μg investigations because of drastically reduced growth temperatures, equilibrium pressures, thermomechanical stress forces, and the absence of Marangoni convection. In most cases, a mirror heating facility is applied (Eyer et al.) and is capable of producing temperature gradients of \( \geq 100 \text{ K cm}^{-1} \) within the liquid zone (Kottler, Langbein, Treuner et al.). The principal scheme of the THM is shown in Figure 4a with respective mirror heating temperature distribution (Fig. 4b). Thus, to establish a triangular approximation of the temperature field within this zone (Fig. 4a).

A steep temperature distribution with a marked maximum in the multicomponent liquid
requires an examination of the thermodiffusive mass transfer contribution during the growth run in a microgravity environment.

We have theoretically analysed the influence of thermodiffusion on the mass distribution within the THM melt-solution zone of the semiconductor systems IV—VI (PbTe), III—V (GaAs, InP) and II—VI (CdTe). The physicochemical parameters are taken from Table 1 and phase diagrams. Whereas the IV—VI and II—VI liquids were treated as associated melt-solutions (Jordan) consisting of PbTe and CdTe molecules and Te solvent atoms, the III—V compounds were assumed to be dissociated (the amount of associated complexes is relatively small (see Osumura and Murakami) consisting of unpaired separate atoms of Ga, As and In, P, respectively.

We solved a system of linear phenomenological equations with free boundary value problem for the only independent diffusion flux \( j_B \), without consideration of Dufour effect. Details of the mathematical analysis are given by Boeck, and Boeck, Rudolph. Only the final formulas important for practical consideration are presented.

The zone length can be written as

\[
l = \frac{T_S - T_0}{G_L} \frac{1}{D_0 m/2D + 1} \sqrt{\left( \frac{T_S - T_0}{G_L} \frac{1}{D_0 m/2D + 1} \right)^2 + \frac{1}{D_0 m/2D + 1} \left( \frac{2m}{G_L} + \frac{D_0 m}{2D} \right) 4a^2}
\]

with the geometrical parameters given in Figure 4.

The asymmetry (difference in location between the middle of the zone and temperature maximum during the movements of the heater) is given as

\[
a = \frac{1}{2} \frac{uml_0}{DG_L(D_0 m/D + 1)}
\]

The temperatures and concentrations at the phase boundaries are taken as

\[
T_1 = T_0 + G_L(z_1 - z_0) = T_S - mc_{B1}
\]

\[
T_2 = T_0 - G_L(z_2 - z_0) = T_S - mc_{B2}
\]
with \( m \) the slope of liquids in the phase diagram. Finally, the maximum heater velocity \( v = v_{\text{max}} \) is found when \( a = l/2 \) and

\[
v_{\text{max}} = D \left\{ -\frac{(D_0 m/D + 1) + (T_3 - T_0)}{ml_0} \right. \\
+ \left. \sqrt{\frac{(D_0 m/D + 1) (T_3 - T_0)}{ml_0}} \right. \\
+ \left. 2 \frac{(D_0 m/D + 1)^2 G_L}{ml_0} \right\}
\]  

(7)

the value of which is equated with the moment of "zones loss" of the heater.

The results of our calculations are given in Figure 5 and 6. Figure 5 shows the maximum growth velocity \( v = v_{\text{max}} \), calculated from equation (7), versus temperature gradient \( G_L \) in front of the growing interface at \( z_1 \) (see Fig. 4) with and without consideration of thermodiffusion. In the case of PbTe—Te and CdTe—Te the value of \( v \) increases...
drastically on account of the Soret effect, which is advantageous for reducing the experiment time under spacelab conditions. On the other hand, for the system In—P a reduction of $v$ is predicted. In the case of Ga—As the Soret coefficient seems negligible.

Figure 6 shows the expected solvent distributions within the THM zone under $\mu g$ conditions for given temperature fields. We have calculated the concentration fields with (TD) and without (OD) consideration of thermodiffusion for $v > 0$ (moving heater), whereas the velocities used are taken from calculated optimum conditions for each material system. As can be seen the Soret effect is predicted to cause an enrichment of tellurium in the middle of the zone in the cases of PbTe and CdTe. On the other hand the growth of InP is characterized by an enrichment of the solvent In at the growing interface which leads to morphological destabilizing (see next section). In the system GaAs a thermodiffusive effect should be negligible.

4. Morphological stability

As well known, the morphological stability requires growth conditions which avoid a constitutional supercooling at the front of the growing interface. Given the concentration field in the melt-solution due to the thermodiffusive mass transfer, the estimation of the critical growth velocity $v_{cr}$ gives

$$v_{cr} \leq \frac{DG_L/m + D_0G_L}{c_{BL} - c_{BS}}$$

where $c_{BL}$ and $c_{BS}$ are the solvent concentrations in the liquid directly at the interface ($z_1$) and in the solid ($c_{BS} = k_0c_{BL}$), respectively.

Some important practical consequences for the above mentioned semiconductor systems are shown in Figure 7. In the case of an actual temperature gradient $G_L$ of 100 K cm$^{-1}$, PbTe crystals grow stable up to 8 mm d$^{-1}$ in comparison with ordinary diffusion which limits the stable crystallization rate to about 4 mm d$^{-1}$. In other words, thermodiffusion increases the morphological stability. An opposite effect will occur in the case of InP growth where the Soret effect destabilizes growth. Therefore, the enrichment of the solvent In at the front of the interface limits the growth velocity to about 1 mm d$^{-1}$.

Note, the results of InP are based on the quite hypothetically assumption that the melt-solution is completely dissociated and a negative Soret coefficient takes places.

Fig. 7. The distribution of the actual temperature $T_{act}$ at the interface $IF$ ($G_L = 100$ K cm$^{-1}$) and the equilibrium temperatures in the cases of thermodiffusion $T_{TD}$ and ordinary diffusion $T_{OD}$ at various heater velocities (given in mm d$^{-1}$ in the parentheses)
(Chien, Mattei; see Tab. 1). However, it is well known (Osamura, Murakami) that, in reality, the relatively high ionicity of InP causes a partially associated melt consisting of species of InP molecules (solute) and In atoms (solvent). For such a case, of course, the Soret coefficient from Table 1 needs to be revised and a thermodiffusive flow of the heavier InP molecules to the cold crystallization front should be taken into account. In fact, recently Danilewsky and Benz obtained at first $\mu g$ THM experiments with InP during D1-mission a markedly increase of the critical growth velocity for the onset of morphological instability at the interface that contradicts our theoretical considerations. Moreover, they found an increased effective diffusion coefficient (i.e. kinetic crystallization velocity) compared to the $1g$ experiment that may give the important hint on the existence of InP species which under $\mu g$ conditions are enriched at the growing interface by the effect of thermodiffusion. Well designed further space experiments should be carried out to accurately analyse this phenomenon of InP:In growth. In general, more $\mu g$ investigations of the effect of thermodiffusion in melt-solutions of semiconductor compounds are necessary in order to test our theoretical estimations.

5. Conclusions

Crystal growth experiments of multicomponent systems without natural and surface tension-driven convection under $\mu g$ conditions require an exact analysis of the total diffusion flux with consideration of the Soret effect in the liquid phase. The greater the mass difference between the solute atoms or molecules ("crystal building blocks") and the solvent atoms, the higher the Soret coefficient leading to destabilizing or stabilizing of the growth conditions. In convectionless modified Bridgman growth arrangements of $\text{Bi}_{1-x}\text{Sb}_x$ mixed crystals the thermodiffusion helps to increase the axial extension of the homogeneous distribution region of the concentration profile in normal freezing.

It has been shown from theoretical point of view that in THM growth configurations an enrichment ($S_T < 0$) or impoverishment ($S_T > 0$) of the solvent at the interface within the liquid zone will be obtained. Therefore, in the case of $\text{CdTe}:\text{Te}$ and $\text{PbTe}:\text{Te}$ the critical growth velocity can be increased drastically under $\mu g$ conditions. Conversely the THM growth of InP single crystals from In-rich solutions needs a reduced crystallization rate. In the system $\text{GaAs}:\text{Ga}$ the Soret effect may be ignored. Identical predictions are valid for the critical growth parameters of $\text{PbTe}$, $\text{CdTe}$, InP, and GaAs in order to avoid morphological instabilities.

Recently published results on THM experiments under microgravity gave the hint on the possible existence of associated InP species in the melt-solutions that contradicts our preconditions and requires the revision of the Soret coefficient. Thus, further space experiments are of importance for the practical test of the presented theoretical calculations i.e. Soret coefficients.

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